# Notice of References Cited Application/Control No. 09/852,883 Applicant(s)/Patent Under Reexamination VORNSAND, STEVEN J. Examiner BRIAN P. YENKE Art Unit Page 1 of 2

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## Application/Control No. O9/852,883 Notice of References Cited Applicant(s)/Patent Under Reexamination VORNSAND, STEVEN J. Examiner BRIAN P. YENKE Art Unit Page 2 of 2

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